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Understanding Embedded - FPGAs (Field Programmable Gate Array)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

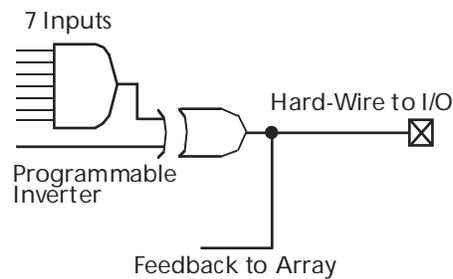
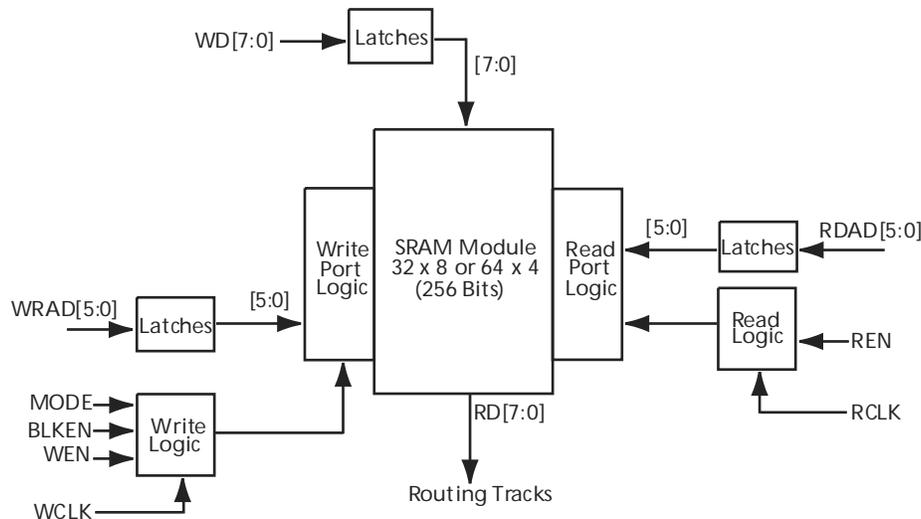
The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details

| | |
|--------------------------------|---|
| Product Status | Active |
| Number of LABs/CLBs | - |
| Number of Logic Elements/Cells | - |
| Total RAM Bits | - |
| Number of I/O | 83 |
| Number of Gates | 24000 |
| Voltage - Supply | 3V ~ 3.6V, 4.75V ~ 5.25V |
| Mounting Type | Surface Mount |
| Operating Temperature | 0°C ~ 70°C (TA) |
| Package / Case | 100-TQFP |
| Supplier Device Package | 100-VQFP (14x14) |
| Purchase URL | https://www.e-xfl.com/product-detail/microchip-technology/a42mx16-fvqg100 |

Tables

| | | |
|----------|--|----|
| Table 1 | Product profile | 1 |
| Table 2 | Plastic Device Resources | 4 |
| Table 3 | Ceramic Device Resources | 4 |
| Table 4 | Temperature Grade Offerings | 5 |
| Table 5 | Speed Grade Offerings | 5 |
| Table 6 | Voltage Support of MX Devices | 13 |
| Table 7 | Fixed Capacitance Values for MX FPGAs (pF) | 16 |
| Table 8 | Device Configuration Options for Probe Capability | 17 |
| Table 9 | Test Access Port Descriptions | 18 |
| Table 10 | Supported BST Public Instructions | 18 |
| Table 11 | Boundary Scan Pin Configuration and Functionality | 19 |
| Table 12 | Absolute Maximum Ratings for 40MX Devices* | 20 |
| Table 13 | Absolute Maximum Ratings for 42MX Devices* | 20 |
| Table 14 | Recommended Operating Conditions | 21 |
| Table 15 | 5V TTL Electrical Specifications | 21 |
| Table 16 | Absolute Maximum Ratings for 40MX Devices* | 22 |
| Table 17 | Absolute Maximum Ratings for 42MX Devices* | 22 |
| Table 18 | Recommended Operating Conditions | 22 |
| Table 19 | 3.3V LVTTTL Electrical Specifications | 23 |
| Table 20 | Absolute Maximum Ratings* | 23 |
| Table 21 | Recommended Operating Conditions | 24 |
| Table 22 | Mixed 5.0V/3.3V Electrical Specifications | 25 |
| Table 23 | DC Specification (5.0 V PCI Signaling) | 25 |
| Table 24 | AC Specifications (5.0V PCI Signaling)* | 26 |
| Table 25 | DC Specification (3.3 V PCI Signaling) | 27 |
| Table 26 | AC Specifications for (3.3 V PCI Signaling)* | 27 |
| Table 27 | Package Thermal Characteristics | 29 |
| Table 28 | 42MX Temperature and Voltage Derating Factors (Normalized to $T_J = 25^\circ\text{C}$, $V_{CCA} = 5.0\text{ V}$) | 38 |
| Table 29 | 40MX Temperature and Voltage Derating Factors(Normalized to $T_J = 25^\circ\text{C}$, $V_{CC} = 5.0\text{ V}$) | 38 |
| Table 30 | 42MX Temperature and Voltage Derating Factors(Normalized to $T_J = 25^\circ\text{C}$, $V_{CCA} = 3.3\text{ V}$) | 39 |
| Table 31 | 40MX Temperature and Voltage Derating Factors (Normalized to $T_J = 25^\circ\text{C}$, $V_{CC} = 3.3\text{ V}$) | 39 |
| Table 32 | Clock Specification for 33 MHz PCI | 40 |
| Table 33 | Timing Parameters for 33 MHz PCI | 40 |
| Table 34 | A40MX02 Timing Characteristics (Nominal 5.0 V Operation) | 41 |
| Table 35 | A40MX02 Timing Characteristics (Nominal 3.3 V Operation) | 43 |
| Table 36 | A40MX04 Timing Characteristics (Nominal 5.0 V Operation) (Worst-Case Commercial Conditions, $V_{CC} = 4.75\text{ V}$, $T_J = 70^\circ\text{C}$) | 46 |
| Table 37 | A40MX04 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, $V_{CC} = 3.0\text{ V}$, $T_J = 70^\circ\text{C}$) | 49 |
| Table 38 | A42MX09 Timing Characteristics (Nominal 5.0 V Operation) (Worst-Case Commercial Conditions, $V_{CCA} = 4.75\text{ V}$, $T_J = 70^\circ\text{C}$) | 52 |
| Table 39 | A42MX09 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, $V_{CCA} = 3.0\text{ V}$, $T_J = 70^\circ\text{C}$) | 56 |
| Table 40 | A42MX16 Timing Characteristics (Nominal 5.0 V Operation) (Worst-Case Commercial Conditions, $V_{CCA} = 4.75\text{ V}$, $T_J = 70^\circ\text{C}$) | 60 |
| Table 41 | A42MX16 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, $V_{CCA} = 3.0\text{ V}$, $T_J = 70^\circ\text{C}$) | 64 |
| Table 42 | A42MX24 Timing Characteristics (Nominal 5.0 V Operation) (Worst-Case Commercial Conditions, $V_{CCA} = 4.75\text{ V}$, $T_J = 70^\circ\text{C}$) | 67 |
| Table 43 | A42MX24 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, $V_{CCA} = 3.0\text{ V}$, $T_J = 70^\circ\text{C}$) | 71 |
| Table 44 | A42MX36 Timing Characteristics (Nominal 5.0 V Operation)(Worst-Case Commercial Conditions, $V_{CCA} = 4.75\text{ V}$, $T_J = 70^\circ\text{C}$) | 75 |
| Table 45 | A42MX36 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, | |

Figure 5 • A42MX24 and A42MX36 D-Module Implementation**Figure 6 • A42MX36 Dual-Port SRAM Block**

3.2.3 Routing Structure

The MX architecture uses vertical and horizontal routing tracks to interconnect the various logic and I/O modules. These routing tracks are metal interconnects that may be continuous or split into segments. Varying segment lengths allow the interconnect of over 90% of design tracks to occur with only two antifuse connections. Segments can be joined together at the ends using antifuses to increase their lengths up to the full length of the track. All interconnects can be accomplished with a maximum of four antifuses.

3.2.3.1 Horizontal Routing

Horizontal routing tracks span the whole row length or are divided into multiple segments and are located in between the rows of modules. Any segment that spans more than one-third of the row length is considered a long horizontal segment. A typical channel is shown in Figure 7, page 10. Within horizontal routing, dedicated routing tracks are used for global clock networks and for power and ground tie-off tracks. Non-dedicated tracks are used for signal nets.

3.2.3.2 Vertical Routing

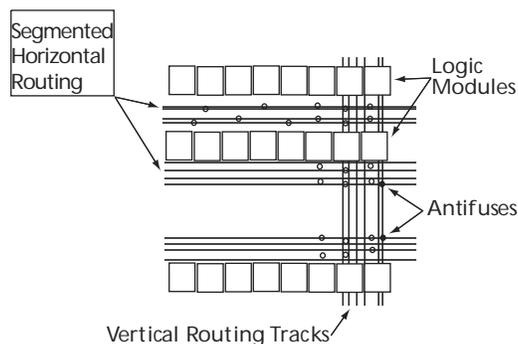
Another set of routing tracks run vertically through the module. There are three types of vertical tracks: input, output, and long. Long tracks span the column length of the module, and can be divided into multiple segments. Each segment in an input track is dedicated to the input of a particular module; each segment in an output track is dedicated to the output of a particular module. Long segments are uncommitted and can be assigned during routing.

Each output segment spans four channels (two above and two below), except near the top and bottom of the array, where edge effects occur. Long vertical tracks contain either one or two segments. An example of vertical routing tracks and segments is shown in Figure 7, page 10.

3.2.3.3 Antifuse Structures

An antifuse is a “normally open” structure. The use of antifuses to implement a programmable logic device results in highly testable structures as well as efficient programming algorithms. There are no pre-existing connections; temporary connections can be made using pass transistors. These temporary connections can isolate individual antifuses to be programmed and individual circuit structures to be tested, which can be done before and after programming. For instance, all metal tracks can be tested for continuity and shorts between adjacent tracks, and the functionality of all logic modules can be verified.

Figure 7 • MX Routing Structure



3.2.4 Clock Networks

The 40MX devices have one global clock distribution network (CLK). A signal can be put on the CLK network by being routed through the CLKBUF buffer.

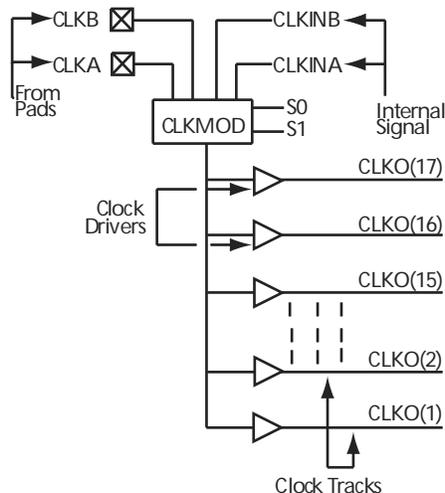
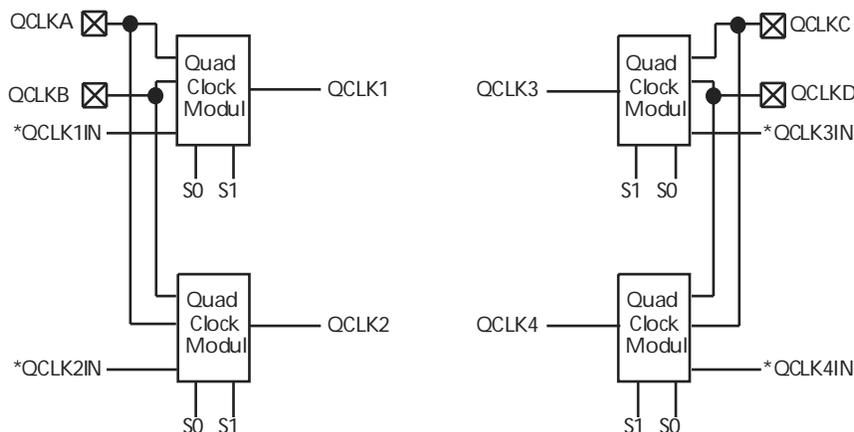
In 42MX devices, there are two low-skew, high-fanout clock distribution networks, referred to as CLKA and CLKB. Each network has a clock module (CLKMOD) that can select the source of the clock signal from any of the following (Figure 8, page 11):

- Externally from the CLKA pad, using CLKBUF buffer
- Externally from the CLKB pad, using CLKBUF buffer
- Internally from the CLKINTA input, using CLKINT buffer
- Internally from the CLKINTB input, using CLKINT buffer

The clock modules are located in the top row of I/O modules. Clock drivers and a dedicated horizontal clock track are located in each horizontal routing channel.

Clock input pads in both 40MX and 42MX devices can also be used as normal I/Os, bypassing the clock networks.

The A42MX36 device has four additional register control resources, called quadrant clock networks (Figure 9, page 11). Each quadrant clock provides a local, high-fanout resource to the contiguous logic modules within its quadrant of the device. Quadrant clock signals can originate from specific I/O pins or from the internal array and can be used as a secondary register clock, register clear, or output enable.

Figure 8 • Clock Networks of 42MX Devices**Figure 9 • Quadrant Clock Network of A42MX36 Devices**

Note: *QCLK1IN, QCLK2IN, QCLK3IN, and QCLK4IN are internally-generated signals.

3.2.5 MultiPlex I/O Modules

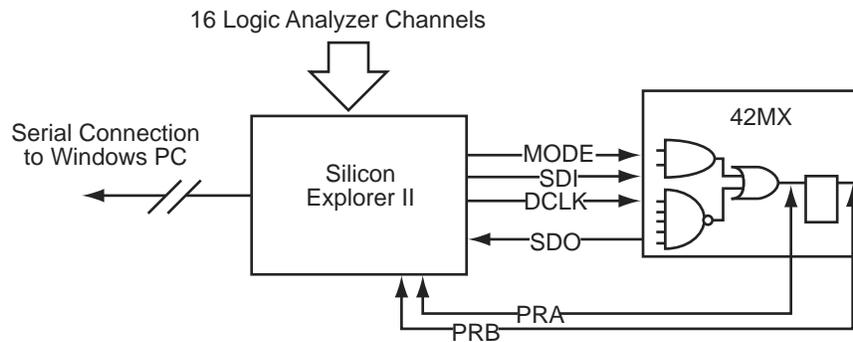
42MX devices feature MultiPlex I/Os and support 5.0 V, 3.3 V, and mixed 3.3 V/5.0 V operations.

The MultiPlex I/O modules provide the interface between the device pins and the logic array. Figure 10, page 12 is a block diagram of the 42MX I/O module. A variety of user functions, determined by a library macro selection, can be implemented in the module. (See the *Antifuse Macro Library Guide* for more information.) All 42MX I/O modules contain tristate buffers, with input and output latches that can be configured for input, output, or bidirectional operation.

All 42MX devices contain flexible I/O structures, where each output pin has a dedicated output-enable control (Figure 10, page 12). The I/O module can be used to latch input or output data, or both, providing fast set-up time. In addition, the Designer software tools can build a D-type flip-flop using a C-module combined with an I/O module to register input and output signals. See the *Antifuse Macro Library Guide* for more details.

A42MX24 and A42MX36 devices also offer selectable PCI output drives, enabling 100% compliance with version 2.1 of the PCI specification. For low-power systems, all inputs and outputs are turned off to reduce current consumption to below 500 μ A.

To achieve 5.0 V or 3.3 V PCI-compliant output drives on A42MX24 and A42MX36 devices, a chip-wide PCI fuse is programmed via the Device Selection Wizard in the Designer software (Figure 11, page 12). When the PCI fuse is not programmed, the output drive is standard.

Figure 13 • Silicon Explorer II Setup with 42MX**Table 8 • Device Configuration Options for Probe Capability**

| Security Fuse(s) Programmed | Mode | PRA, PRB ¹ | SDI, SDO, DCLK ¹ |
|-----------------------------|------|------------------------|-----------------------------|
| No | LOW | User I/Os ² | User I/Os ² |
| No | HIGH | Probe Circuit Outputs | Probe Circuit Inputs |
| Yes | – | Probe Circuit Secured | Probe Circuit Secured |

1. Avoid using SDI, SDO, DCLK, PRA and PRB pins as input or bidirectional ports. Since these pins are active during probing, input signals will not pass through these pins and may cause contention.
2. If no user signal is assigned to these pins, they will behave as unused I/Os in this mode. See the Pin Descriptions, page 83 for information on unused I/O pins

3.4.7 Design Consideration

It is recommended to use a series 70Ω termination resistor on every probe connector (SDI, SDO, MODE, DCLK, PRA and PRB). The 70 Ω series termination is used to prevent data transmission corruption during probing and reading back the checksum.

3.4.8 IEEE Standard 1149.1 Boundary Scan Test (BST) Circuitry

42MX24 and 42MX36 devices are compatible with IEEE Standard 1149.1 (informally known as Joint Testing Action Group Standard or JTAG), which defines a set of hardware architecture and mechanisms for cost-effective board-level testing. The basic MX boundary-scan logic circuit is composed of the TAP (test access port), TAP controller, test data registers and instruction register (Figure 14, page 18). This circuit supports all mandatory IEEE 1149.1 instructions (EXTEST, SAMPLE/PRELOAD and BYPASS) and some optional instructions. Table 9, page 18 describes the ports that control JTAG testing, while Table 10, page 18 describes the test instructions supported by these MX devices.

Each test section is accessed through the TAP, which has four associated pins: TCK (test clock input), TDI and TDO (test data input and output), and TMS (test mode selector).

The TAP controller is a four-bit state machine. The '1's and '0's represent the values that must be present at TMS at a rising edge of TCK for the given state transition to occur. IR and DR indicate that the instruction register or the data register is operating in that state.

The TAP controller receives two control inputs (TMS and TCK) and generates control and clock signals for the rest of the test logic architecture. On power-up, the TAP controller enters the Test-Logic-Reset state. To guarantee a reset of the controller from any of the possible states, TMS must remain high for five TCK cycles.

42MX24 and 42MX36 devices support three types of test data registers: bypass, device identification, and boundary scan. The bypass register is selected when no other register needs to be accessed in a device. This speeds up test data transfer to other devices in a test data path. The 32-bit device identification register is a shift register with four fields (lowest significant byte (LSB), ID number, part number and version). The boundary-scan register observes and controls the state of each I/O pin.

reliability. Devices should not be operated outside the recommended operating conditions.

Table 21 • Recommended Operating Conditions

| Parameter | Commercial | Industrial | Military | Units |
|--------------------|--------------|------------|-------------|-------|
| Temperature Range* | 0 to +70 | −40 to +85 | −55 to +125 | °C |
| VCCA | 4.75 to 5.25 | 4.5 to 5.5 | 4.5 to 5.5 | V |
| VCCI | 3.14 to 3.47 | 3.0 to 3.6 | 3.0 to 3.6 | V |

Note: *Ambient temperature (T_A) is used for commercial and industrial grades; case temperature (T_C) is used for military grades.

Figure 22 • AC Test Loads

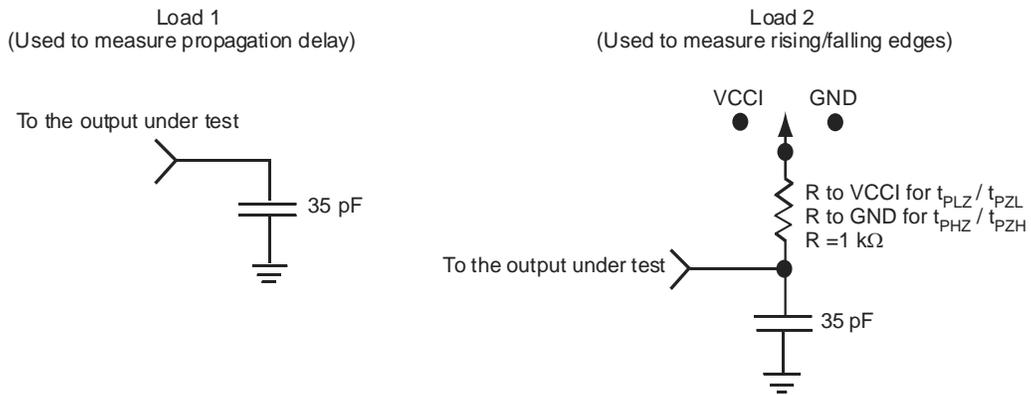


Figure 23 • Input Buffer Delays

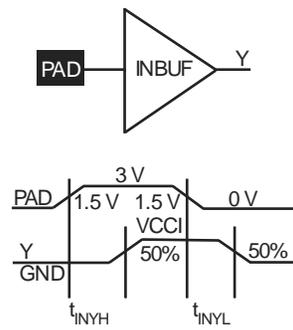


Figure 24 • Module Delays

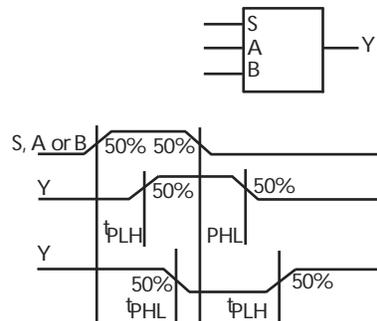


Table 38 • A42MX09 Timing Characteristics (Nominal 5.0 V Operation) (continued)(Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C)

| Parameter / Description | -3 Speed | | -2 Speed | | -1 Speed | | Std Speed | | -F Speed | | Units |
|--|---|------|----------|------|----------|------|-----------|------|----------|------|-------|
| | Min. | Max. | Min. | Max. | Min. | Max. | Min. | Max. | Min. | Max. | |
| CMOS Output Module Timing⁵ | | | | | | | | | | | |
| t _{DLH} | Data-to-Pad HIGH | 2.4 | 2.7 | 3.1 | 3.6 | 5.1 | ns | | | | |
| t _{DHL} | Data-to-Pad LOW | 2.9 | 3.2 | 3.6 | 4.3 | 6.0 | ns | | | | |
| t _{ENZH} | Enable Pad Z to HIGH | 2.7 | 2.9 | 3.3 | 3.9 | 5.5 | ns | | | | |
| t _{ENZL} | Enable Pad Z to LOW | 2.9 | 3.2 | 3.7 | 4.3 | 6.1 | ns | | | | |
| t _{ENHZ} | Enable Pad HIGH to Z | 4.9 | 5.4 | 6.2 | 7.3 | 10.2 | ns | | | | |
| t _{ENLZ} | Enable Pad LOW to Z | 5.3 | 5.9 | 6.7 | 7.9 | 11.1 | ns | | | | |
| t _{GLH} | G-to-Pad HIGH | 4.2 | 4.6 | 5.2 | 6.1 | 8.6 | ns | | | | |
| t _{GHL} | G-to-Pad LOW | 4.2 | 4.6 | 5.2 | 6.1 | 8.6 | ns | | | | |
| t _{LSU} | I/O Latch Set-Up | 0.5 | 0.5 | 0.6 | 0.7 | 1.0 | ns | | | | |
| t _{LH} | I/O Latch Hold | 0.0 | 0.0 | 0.0 | 0.0 | 0.0 | ns | | | | |
| t _{LCO} | I/O Latch Clock-to-Out (Pad-to-Pad), 64 Clock Loading | 5.2 | 5.8 | 6.6 | 7.7 | 10.8 | ns | | | | |
| t _{ACO} | Array Clock-to-Out (Pad-to-Pad), 64 Clock Loading | 7.4 | 8.2 | 9.3 | 10.9 | 15.3 | ns | | | | |
| d _{TLH} | Capacity Loading, LOW to HIGH | 0.03 | 0.03 | 0.03 | 0.04 | 0.06 | ns/pF | | | | |
| d _{THL} | Capacity Loading, HIGH to LOW | 0.04 | 0.04 | 0.04 | 0.05 | 0.07 | ns/pF | | | | |

1. For dual-module macros, use t_{PD1} + t_{RD1} + t_{PDn}, t_{CO} + t_{RD1} + t_{PDn}, or t_{PD1} + t_{RD1} + t_{SUD}, whichever is appropriate.
2. Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance.
3. Data applies to macros based on the S-module. Timing parameters for sequential macros constructed from C-modules can be obtained from the Timer utility.
4. Set-up and hold timing parameters for the input buffer latch are defined with respect to the PAD and the D input. External setup/hold timing parameters must account for delay from an external PAD signal to the G inputs. Delay from an external PAD signal to the G input subtracts (adds) to the internal setup (hold) time.
5. Delays based on 35 pF loading

Table 39 • A42MX09 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCCA = 3.0 V, T_J = 70°C)

| Parameter / Description | -3 Speed | | -2 Speed | | -1 Speed | | Std Speed | | -F Speed | | Units |
|--|------------------------------|------|----------|------|----------|------|-----------|------|----------|------|-------|
| | Min. | Max. | Min. | Max. | Min. | Max. | Min. | Max. | Min. | Max. | |
| Logic Module Propagation Delays¹ | | | | | | | | | | | |
| t _{PD1} | Single Module | 1.6 | 1.8 | 2.1 | 2.5 | 3.5 | ns | | | | |
| t _{CO} | Sequential Clock-to-Q | 1.8 | 2.0 | 2.3 | 2.7 | 3.8 | ns | | | | |
| t _{GO} | Latch G-to-Q | 1.7 | 1.9 | 2.1 | 2.5 | 3.5 | ns | | | | |
| t _{RS} | Flip-Flop (Latch) Reset-to-Q | 2.0 | 2.2 | 2.5 | 2.9 | 4.1 | ns | | | | |
| Logic Module Predicted Routing Delays² | | | | | | | | | | | |
| t _{RD1} | FO = 1 Routing Delay | 1.0 | 1.1 | 1.2 | 1.4 | 2.0 | ns | | | | |
| t _{RD2} | FO = 2 Routing Delay | 1.3 | 1.4 | 1.6 | 1.9 | 2.7 | ns | | | | |
| t _{RD3} | FO = 3 Routing Delay | 1.6 | 1.8 | 2.0 | 2.4 | 3.3 | ns | | | | |

Table 40 • A42MX16 Timing Characteristics (Nominal 5.0 V Operation) (continued)(Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C)

| Parameter / Description | | -3 Speed | | -2 Speed | | -1 Speed | | Std Speed | | -F Speed | | Units |
|--|---|----------|------|----------|------|----------|------|-----------|------|----------|------|-------|
| | | Min. | Max. | Min. | Max. | Min. | Max. | Min. | Max. | Min. | Max. | |
| t _{RD3} | FO = 3 Routing Delay | | 1.3 | | 1.4 | | 1.6 | | 1.9 | | 2.7 | ns |
| t _{RD4} | FO = 4 Routing Delay | | 1.6 | | 1.7 | | 2.0 | | 2.3 | | 3.2 | ns |
| t _{RD8} | FO = 8 Routing Delay | | 2.6 | | 2.9 | | 3.2 | | 3.8 | | 5.3 | ns |
| Logic Module Sequential Timing^{3,4} | | | | | | | | | | | | |
| t _{SUD} | Flip-Flop (Latch) Data Input Set-Up | | 0.3 | | 0.4 | | 0.4 | | 0.5 | | 0.7 | ns |
| t _{HD} | Flip-Flop (Latch) Data Input Hold | | 0.0 | | 0.0 | | 0.0 | | 0.0 | | 0.0 | ns |
| t _{SUENA} | Flip-Flop (Latch) Enable Set-Up | | 0.7 | | 0.8 | | 0.9 | | 1.0 | | 1.4 | ns |
| t _{HENA} | Flip-Flop (Latch) Enable Hold | | 0.0 | | 0.0 | | 0.0 | | 0.0 | | 0.0 | ns |
| t _{WCLKA} | Flip-Flop (Latch) Clock Active Pulse Width | | 3.4 | | 3.8 | | 4.3 | | 5.0 | | 7.1 | ns |
| t _{WASYN} | Flip-Flop (Latch) Asynchronous Pulse Width | | 4.5 | | 5.0 | | 5.6 | | 6.6 | | 9.2 | ns |
| t _A | Flip-Flop Clock Input Period | | 6.8 | | 7.6 | | 8.6 | | 10.1 | | 14.1 | ns |
| t _{INH} | Input Buffer Latch Hold | | 0.0 | | 0.0 | | 0.0 | | 0.0 | | 0.0 | ns |
| t _{INSU} | Input Buffer Latch Set-Up | | 0.5 | | 0.5 | | 0.6 | | 0.7 | | 1.0 | ns |
| t _{OUTH} | Output Buffer Latch Hold | | 0.0 | | 0.0 | | 0.0 | | 0.0 | | 0.0 | ns |
| t _{OUTSU} | Output Buffer Latch Set-Up | | 0.5 | | 0.5 | | 0.6 | | 0.7 | | 1.0 | ns |
| f _{MAX} | Flip-Flop (Latch) Clock Frequency | | 215 | | 195 | | 179 | | 156 | | 94 | MHz |
| Input Module Propagation Delays | | | | | | | | | | | | |
| t _{INYH} | Pad-to-Y HIGH | | 1.1 | | 1.2 | | 1.3 | | 1.6 | | 2.2 | ns |
| t _{INYL} | Pad-to-Y LOW | | 0.8 | | 0.9 | | 1.0 | | 1.2 | | 1.7 | ns |
| t _{INGH} | G to Y HIGH | | 1.4 | | 1.6 | | 1.8 | | 2.1 | | 2.9 | ns |
| t _{INGL} | G to Y LOW | | 1.4 | | 1.6 | | 1.8 | | 2.1 | | 2.9 | ns |
| Input Module Predicted Routing Delays² | | | | | | | | | | | | |
| t _{IRD1} | FO = 1 Routing Delay | | 1.8 | | 2.0 | | 2.3 | | 2.7 | | 4.0 | ns |
| t _{IRD2} | FO = 2 Routing Delay | | 2.1 | | 2.3 | | 2.6 | | 3.1 | | 4.3 | ns |
| t _{IRD3} | FO = 3 Routing Delay | | 2.3 | | 2.6 | | 3.0 | | 3.5 | | 4.9 | ns |
| t _{IRD4} | FO = 4 Routing Delay | | 2.6 | | 3.0 | | 3.3 | | 3.9 | | 5.4 | ns |
| t _{IRD8} | FO = 8 Routing Delay | | 3.6 | | 4.0 | | 4.6 | | 5.4 | | 7.5 | ns |
| Global Clock Network | | | | | | | | | | | | |
| t _{CKH} | Input LOW to HIGH | FO = 32 | 2.6 | | 2.9 | | 3.3 | | 3.9 | | 5.4 | ns |
| | | FO = 384 | 2.9 | | 3.2 | | 3.6 | | 4.3 | | 6.0 | ns |
| t _{CKL} | Input HIGH to LOW | FO = 32 | 3.8 | | 4.2 | | 4.8 | | 5.6 | | 7.8 | ns |
| | | FO = 384 | 4.5 | | 5.0 | | 5.6 | | 6.6 | | 9.2 | ns |
| t _{PWH} | Minimum Pulse Width HIGH | FO = 32 | 3.2 | | 3.5 | | 4.0 | | 4.7 | | 6.6 | ns |
| | | FO = 384 | 3.7 | | 4.1 | | 4.6 | | 5.4 | | 7.6 | ns |

Table 40 • A42MX16 Timing Characteristics (Nominal 5.0 V Operation) (continued)(Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C)

| Parameter / Description | -3 Speed | | -2 Speed | | -1 Speed | | Std Speed | | -F Speed | | Units |
|--|--|------|----------|------|----------|------|-----------|------|----------|------|-------|
| | Min. | Max. | Min. | Max. | Min. | Max. | Min. | Max. | Min. | Max. | |
| CMOS Output Module Timing⁵ | | | | | | | | | | | |
| t _{DLH} | Data-to-Pad HIGH | 3.2 | 3.6 | 4.0 | 4.7 | 6.6 | ns | | | | |
| t _{DHL} | Data-to-Pad LOW | 2.5 | 2.7 | 3.1 | 3.6 | 5.1 | ns | | | | |
| t _{ENZH} | Enable Pad Z to HIGH | 2.7 | 3.0 | 3.4 | 4.0 | 5.6 | ns | | | | |
| t _{ENZL} | Enable Pad Z to LOW | 3.0 | 3.3 | 3.8 | 4.4 | 6.2 | ns | | | | |
| t _{ENHZ} | Enable Pad HIGH to Z | 5.4 | 6.0 | 6.8 | 8.0 | 11.2 | ns | | | | |
| t _{ENLZ} | Enable Pad LOW to Z | 5.0 | 5.6 | 6.3 | 7.4 | 10.4 | ns | | | | |
| t _{GLH} | G-to-Pad HIGH | 5.1 | 5.6 | 6.4 | 7.5 | 10.5 | ns | | | | |
| t _{GHL} | G-to-Pad LOW | 5.1 | 5.6 | 6.4 | 7.5 | 10.5 | ns | | | | |
| t _{LCO} | I/O Latch Clock-to-Out (Pad-to-Pad), 64 Clock Loading | 5.7 | 6.3 | 7.1 | 8.4 | 11.9 | ns | | | | |
| t _{ACO} | Array Clock-to-Out (Pad-to-Pad), 64 Clock Loading | 8.0 | 8.9 | 10.1 | 11.9 | 16.7 | ns | | | | |
| d _{TLH} | Capacitive Loading, LOW to HIGH | 0.03 | 0.03 | 0.03 | 0.04 | 0.06 | ns/pF | | | | |

1. For dual-module macros, use t_{PD1} + t_{RD1} + t_{PDn}, t_{CO} + t_{RD1} + t_{PDn}, or t_{PD1} + t_{RD1} + t_{SUD}, point and position whichever is appropriate.
2. Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance.
3. *Data applies to macros based on the S-module. Timing parameters for sequential macros constructed from C-modules can be obtained from the Timer utility.*
4. Set-up and hold timing parameters for the input buffer latch are defined with respect to the PAD and the D input. External setup/hold timing parameters must account for delay from an external PAD signal to the G inputs. Delay from an external PAD signal to the G input subtracts (adds) to the internal setup (hold) time.
5. Delays based on 35 pF loading

Table 41 • A42MX16 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCCA = 3.0 V, T_J = 70°C)

| Parameter / Description | -3 Speed | | -2 Speed | | -1 Speed | | Std Speed | | -F Speed | | Units |
|--|------------------------------|------|----------|------|----------|------|-----------|------|----------|------|-------|
| | Min. | Max. | Min. | Max. | Min. | Max. | Min. | Max. | Min. | Max. | |
| Logic Module Propagation Delays¹ | | | | | | | | | | | |
| t _{PD1} | Single Module | 1.9 | 2.1 | 2.4 | 2.8 | 4.0 | ns | | | | |
| t _{CO} | Sequential Clock-to-Q | 2.0 | 2.2 | 2.5 | 3.0 | 4.2 | ns | | | | |
| t _{GO} | Latch G-to-Q | 1.9 | 2.1 | 2.4 | 2.8 | 4.0 | ns | | | | |
| t _{RS} | Flip-Flop (Latch) Reset-to-Q | 2.2 | 2.4 | 2.8 | 3.3 | 4.6 | ns | | | | |
| Logic Module Predicted Routing Delays² | | | | | | | | | | | |
| t _{RD1} | FO = 1 Routing Delay | 1.1 | 1.2 | 1.4 | 1.6 | 2.3 | ns | | | | |
| t _{RD2} | FO = 2 Routing Delay | 1.5 | 1.6 | 1.8 | 2.1 | 3.0 | ns | | | | |
| t _{RD3} | FO = 3 Routing Delay | 1.8 | 2.0 | 2.3 | 2.7 | 3.8 | ns | | | | |
| t _{RD4} | FO = 4 Routing Delay | 2.2 | 2.4 | 2.7 | 3.2 | 4.5 | ns | | | | |
| t _{RD8} | FO = 8 Routing Delay | 3.6 | 4.0 | 4.5 | 5.3 | 7.5 | ns | | | | |

Table 44 • A42MX36 Timing Characteristics (Nominal 5.0 V Operation)(Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C)

| Parameter / Description | | -3 Speed | | -2 Speed | | -1 Speed | | Std Speed | | -F Speed | | Units |
|--|-------------------------------------|----------|------|----------|------|----------|------|-----------|------|----------|------|-------|
| | | Min. | Max. | Min. | Max. | Min. | Max. | Min. | Max. | Min. | Max. | |
| Asynchronous SRAM Operations | | | | | | | | | | | | |
| t _{RPD} | Asynchronous Access Time | | 8.1 | | 9.0 | | 10.2 | | 12.0 | | 16.8 | ns |
| t _{RDADV} | Read Address Valid | | 8.8 | | 9.8 | | 11.1 | | 13.0 | | 18.2 | ns |
| t _{ADSU} | Address/Data Set-Up Time | | 1.6 | | 1.8 | | 2.0 | | 2.4 | | 3.4 | ns |
| t _{ADH} | Address/Data Hold Time | | 0.0 | | 0.0 | | 0.0 | | 0.0 | | 0.0 | ns |
| t _{RENSUA} | Read Enable Set-Up to Address Valid | | 0.6 | | 0.7 | | 0.8 | | 0.9 | | 1.3 | ns |
| t _{RENHA} | Read Enable Hold | | 3.4 | | 3.8 | | 4.3 | | 5.0 | | 7.0 | ns |
| t _{WENSU} | Write Enable Set-Up | | 2.7 | | 3.0 | | 3.4 | | 4.0 | | 5.6 | ns |
| t _{WENH} | Write Enable Hold | | 0.0 | | 0.0 | | 0.0 | | 0.0 | | 0.0 | ns |
| t _{DOH} | Data Out Hold Time | | 1.2 | | 1.3 | | 1.5 | | 1.8 | | 2.5 | ns |
| Input Module Propagation Delays | | | | | | | | | | | | |
| t _{INPY} | Input Data Pad-to-Y | | 1.0 | | 1.1 | | 1.3 | | 1.5 | | 2.1 | ns |
| t _{INGO} | Input Latch Gate-to-Output | | 1.4 | | 1.6 | | 1.8 | | 2.1 | | 2.9 | ns |
| t _{INH} | Input Latch Hold | | 0.0 | | 0.0 | | 0.0 | | 0.0 | | 0.0 | ns |
| t _{INSU} | Input Latch Set-Up | | 0.5 | | 0.5 | | 0.6 | | 0.7 | | 1.0 | ns |
| t _{ILA} | Latch Active Pulse Width | | 4.7 | | 5.2 | | 5.9 | | 6.9 | | 9.7 | ns |
| Input Module Predicted Routing Delays² | | | | | | | | | | | | |
| t _{IRD1} | FO = 1 Routing Delay | | 2.0 | | 2.2 | | 2.5 | | 2.9 | | 4.1 | ns |
| t _{IRD2} | FO = 2 Routing Delay | | 2.3 | | 2.6 | | 2.9 | | 3.4 | | 4.8 | ns |
| t _{IRD3} | FO = 3 Routing Delay | | 2.6 | | 2.9 | | 3.3 | | 3.9 | | 5.5 | ns |
| t _{IRD4} | FO = 4 Routing Delay | | 3.0 | | 3.3 | | 3.8 | | 4.4 | | 6.2 | ns |
| t _{IRD8} | FO = 8 Routing Delay | | 4.3 | | 4.8 | | 5.5 | | 6.4 | | 9.0 | ns |
| Global Clock Network | | | | | | | | | | | | |
| t _{CKH} | Input LOW to HIGH | FO = 32 | 2.7 | | 3.0 | | 3.4 | | 4.0 | | 5.6 | ns |
| | | FO = 635 | 3.0 | | 3.3 | | 3.8 | | 4.4 | | 6.2 | ns |
| t _{CKL} | Input HIGH to LOW | FO = 32 | 3.8 | | 4.2 | | 4.8 | | 5.6 | | 7.8 | ns |
| | | FO = 635 | 4.9 | | 5.4 | | 6.1 | | 7.2 | | 10.1 | ns |
| t _{PWH} | Minimum Pulse Width HIGH | FO = 32 | 1.8 | | 2.0 | | 2.2 | | 2.6 | | 3.6 | ns |
| | | FO = 635 | 2.0 | | 2.2 | | 2.5 | | 2.9 | | 4.1 | ns |
| t _{PWL} | Minimum Pulse Width LOW | FO = 32 | 1.8 | | 2.0 | | 2.2 | | 2.6 | | 3.6 | ns |
| | | FO = 635 | 2.0 | | 2.2 | | 2.5 | | 2.9 | | 4.1 | ns |
| t _{CKSW} | Maximum Skew | FO = 32 | 0.8 | | 0.8 | | 0.9 | | 1.0 | | 1.4 | ns |
| | | FO = 635 | 0.8 | | 0.8 | | 0.9 | | 1.0 | | 1.4 | ns |

Table 45 • A42MX36 Timing Characteristics (Nominal 3.3 V Operation) (continued)(Worst-Case Commercial Conditions, VCCA = 3.0 V, T_J = 70°C)

| Parameter / Description | -3 Speed | | -2 Speed | | -1 Speed | | Std Speed | | -F Speed | | Units |
|--|----------|------|----------|------|----------|------|-----------|------|----------|------|-------|
| | Min. | Max. | Min. | Max. | Min. | Max. | Min. | Max. | Min. | Max. | |
| t _{RD5} FO = 8 Routing Delay | | 4.6 | | 5.2 | | 5.8 | | 6.9 | | 9.6 | ns |
| t _{RDD} Decode-to-Output Routing Delay | | 0.5 | | 0.5 | | 0.6 | | 0.7 | | 1.0 | ns |
| Logic Module Sequential Timing^{3, 4} | | | | | | | | | | | |
| t _{CO} Flip-Flop Clock-to-Output | | 1.8 | | 2.0 | | 2.3 | | 2.7 | | 3.7 | ns |
| t _{GO} Latch Gate-to-Output | | 1.8 | | 2.0 | | 2.3 | | 2.7 | | 3.7 | ns |
| t _{SUD} Flip-Flop (Latch) Set-Up Time | 0.4 | | 0.5 | | 0.6 | | 0.7 | | 0.9 | | ns |
| t _{HD} Flip-Flop (Latch) Hold Time | 0.0 | | 0.0 | | 0.0 | | 0.0 | | 0.0 | | ns |
| t _{RO} Flip-Flop (Latch) Reset-to-Output | | 2.2 | | 2.4 | | 2.7 | | 3.2 | | 4.5 | ns |
| t _{SUENA} Flip-Flop (Latch) Enable Set-Up | 1.0 | | 1.1 | | 1.2 | | 1.4 | | 2.0 | | ns |
| t _{HENA} Flip-Flop (Latch) Enable Hold | 0.0 | | 0.0 | | 0.0 | | 0.0 | | 0.0 | | ns |
| t _{WCLKA} Flip-Flop (Latch) Clock Active Pulse Width | 4.6 | | 5.2 | | 5.8 | | 6.9 | | 9.6 | | ns |
| t _{WASYN} Flip-Flop (Latch) Asynchronous Pulse Width | 6.1 | | 6.8 | | 7.7 | | 9.0 | | 12.6 | | ns |
| Synchronous SRAM Operations | | | | | | | | | | | |
| t _{RC} Read Cycle Time | | 9.5 | | 10.5 | | 11.9 | | 14.0 | | 19.6 | ns |
| t _{WC} Write Cycle Time | | 9.5 | | 10.5 | | 11.9 | | 14.0 | | 19.6 | ns |
| t _{RCKHL} Clock HIGH/LOW Time | | 4.8 | | 5.3 | | 6.0 | | 7.0 | | 9.8 | ns |
| t _{RCO} Data Valid After Clock HIGH/LOW | | 4.8 | | 5.3 | | 6.0 | | 7.0 | | 9.8 | ns |
| t _{ADSU} Address/Data Set-Up Time | | 2.3 | | 2.5 | | 2.8 | | 3.4 | | 4.8 | ns |

Table 48 • PL68

| PL68 | | |
|-------------------|-------------------------|-------------------------|
| Pin Number | A40MX02 Function | A40MX04 Function |
| 24 | I/O | I/O |
| 25 | VCC | VCC |
| 26 | I/O | I/O |
| 27 | I/O | I/O |
| 28 | I/O | I/O |
| 29 | I/O | I/O |
| 30 | I/O | I/O |
| 31 | I/O | I/O |
| 32 | GND | GND |
| 33 | I/O | I/O |
| 34 | I/O | I/O |
| 35 | I/O | I/O |
| 36 | I/O | I/O |
| 37 | I/O | I/O |
| 38 | VCC | VCC |
| 39 | I/O | I/O |
| 40 | I/O | I/O |
| 41 | I/O | I/O |
| 42 | I/O | I/O |
| 43 | I/O | I/O |
| 44 | I/O | I/O |
| 45 | I/O | I/O |
| 46 | I/O | I/O |
| 47 | I/O | I/O |
| 48 | I/O | I/O |
| 49 | GND | GND |
| 50 | I/O | I/O |
| 51 | I/O | I/O |
| 52 | CLK, I/O | CLK, I/O |
| 53 | I/O | I/O |
| 54 | MODE | MODE |
| 55 | VCC | VCC |
| 56 | SDI, I/O | SDI, I/O |
| 57 | DCLK, I/O | DCLK, I/O |
| 58 | PRA, I/O | PRA, I/O |
| 59 | PRB, I/O | PRB, I/O |
| 60 | I/O | I/O |

Figure 44 • PQ208

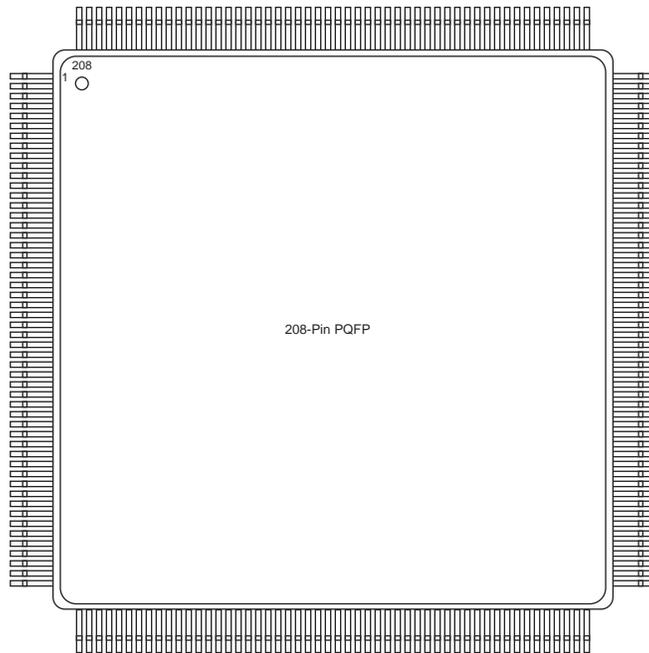


Table 53 • PQ208

| PQ208 | | | |
|------------|------------------|------------------|------------------|
| Pin Number | A42MX16 Function | A42MX24 Function | A42MX36 Function |
| 1 | GND | GND | GND |
| 2 | NC | VCCA | VCCA |
| 3 | MODE | MODE | MODE |
| 4 | I/O | I/O | I/O |
| 5 | I/O | I/O | I/O |
| 6 | I/O | I/O | I/O |
| 7 | I/O | I/O | I/O |
| 8 | I/O | I/O | I/O |
| 9 | NC | I/O | I/O |
| 10 | NC | I/O | I/O |
| 11 | NC | I/O | I/O |
| 12 | I/O | I/O | I/O |
| 13 | I/O | I/O | I/O |
| 14 | I/O | I/O | I/O |
| 15 | I/O | I/O | I/O |
| 16 | NC | I/O | I/O |
| 17 | VCCA | VCCA | VCCA |
| 18 | I/O | I/O | I/O |
| 19 | I/O | I/O | I/O |
| 20 | I/O | I/O | I/O |

Table 54 • PQ240

| PQ240 | |
|-------------------|-------------------------|
| Pin Number | A42MX36 Function |
| 15 | QCLKC, I/O |
| 16 | I/O |
| 17 | WD, I/O |
| 18 | WD, I/O |
| 19 | I/O |
| 20 | I/O |
| 21 | WD, I/O |
| 22 | WD, I/O |
| 23 | I/O |
| 24 | PRB, I/O |
| 25 | I/O |
| 26 | CLKB, I/O |
| 27 | I/O |
| 28 | GND |
| 29 | VCCA |
| 30 | VCCI |
| 31 | I/O |
| 32 | CLKA, I/O |
| 33 | I/O |
| 34 | PRA, I/O |
| 35 | I/O |
| 36 | I/O |
| 37 | WD, I/O |
| 38 | WD, I/O |
| 39 | I/O |
| 40 | I/O |
| 41 | I/O |
| 42 | I/O |
| 43 | I/O |
| 44 | I/O |
| 45 | QCLKD, I/O |
| 46 | I/O |
| 47 | WD, I/O |
| 48 | WD, I/O |
| 49 | I/O |
| 50 | I/O |
| 51 | I/O |

Table 54 • PQ240

| PQ240 | |
|-------------------|-------------------------|
| Pin Number | A42MX36 Function |
| 89 | VCCI |
| 90 | VCCA |
| 91 | LP |
| 92 | TCK, I/O |
| 93 | I/O |
| 94 | GND |
| 95 | I/O |
| 96 | I/O |
| 97 | I/O |
| 98 | I/O |
| 99 | I/O |
| 100 | I/O |
| 101 | I/O |
| 102 | I/O |
| 103 | I/O |
| 104 | I/O |
| 105 | I/O |
| 106 | I/O |
| 107 | I/O |
| 108 | VCCI |
| 109 | I/O |
| 110 | I/O |
| 111 | I/O |
| 112 | I/O |
| 113 | I/O |
| 114 | I/O |
| 115 | I/O |
| 116 | I/O |
| 117 | I/O |
| 118 | VCCA |
| 119 | GND |
| 120 | GND |
| 121 | GND |
| 122 | I/O |
| 123 | SDO, TDO, I/O |
| 124 | I/O |
| 125 | WD, I/O |

Table 55 • VQ80

| VQ80 | | |
|-------------------|-----------------------------|-----------------------------|
| Pin Number | A40MX02 Function | A40MX04 Function |
| 13 | VCC | VCC |
| 14 | I/O | I/O |
| 15 | I/O | I/O |
| 16 | I/O | I/O |
| 17 | NC | I/O |
| 18 | NC | I/O |
| 19 | NC | I/O |
| 20 | VCC | VCC |
| 21 | I/O | I/O |
| 22 | I/O | I/O |
| 23 | I/O | I/O |
| 24 | I/O | I/O |
| 25 | I/O | I/O |
| 26 | I/O | I/O |
| 27 | GND | GND |
| 28 | I/O | I/O |
| 29 | I/O | I/O |
| 30 | I/O | I/O |
| 31 | I/O | I/O |
| 32 | I/O | I/O |
| 33 | VCC | VCC |
| 34 | I/O | I/O |
| 35 | I/O | I/O |
| 36 | I/O | I/O |
| 37 | I/O | I/O |
| 38 | I/O | I/O |
| 39 | I/O | I/O |
| 40 | I/O | I/O |
| 41 | NC | I/O |
| 42 | NC | I/O |
| 43 | NC | I/O |
| 44 | I/O | I/O |
| 45 | I/O | I/O |
| 46 | I/O | I/O |
| 47 | GND | GND |
| 48 | I/O | I/O |

Table 55 • VQ80

| VQ80 | | |
|-------------------|-----------------------------|-----------------------------|
| Pin Number | A40MX02 Function | A40MX04 Function |
| 49 | I/O | I/O |
| 50 | CLK, I/O | CLK, I/O |
| 51 | I/O | I/O |
| 52 | MODE | MODE |
| 53 | VCC | VCC |
| 54 | NC | I/O |
| 55 | NC | I/O |
| 56 | NC | I/O |
| 57 | SDI, I/O | SDI, I/O |
| 58 | DCLK, I/O | DCLK, I/O |
| 59 | PRA, I/O | PRA, I/O |
| 60 | NC | NC |
| 61 | PRB, I/O | PRB, I/O |
| 62 | I/O | I/O |
| 63 | I/O | I/O |
| 64 | I/O | I/O |
| 65 | I/O | I/O |
| 66 | I/O | I/O |
| 67 | I/O | I/O |
| 68 | GND | GND |
| 69 | I/O | I/O |
| 70 | I/O | I/O |
| 71 | I/O | I/O |
| 72 | I/O | I/O |
| 73 | I/O | I/O |
| 74 | VCC | VCC |
| 75 | I/O | I/O |
| 76 | I/O | I/O |
| 77 | I/O | I/O |
| 78 | I/O | I/O |
| 79 | I/O | I/O |
| 80 | I/O | I/O |

Table 60 • BG272

| BG272 | |
|-------------------|-------------------------|
| Pin Number | A42MX36 Function |
| J9 | GND |
| J10 | GND |
| J11 | GND |
| J12 | GND |
| J17 | VCCA |
| J18 | I/O |
| J19 | I/O |
| J20 | I/O |
| K1 | I/O |
| K2 | I/O |
| K3 | I/O |
| K4 | VCCI |
| K9 | GND |
| K10 | GND |
| K11 | GND |
| K12 | GND |
| K17 | I/O |
| K18 | VCCA |
| K19 | VCCA |
| K20 | LP |
| L1 | I/O |
| L2 | I/O |
| L3 | VCCA |
| L4 | VCCA |
| L9 | GND |
| L10 | GND |
| L11 | GND |
| L12 | GND |
| L17 | VCCI |
| L18 | I/O |
| L19 | I/O |
| L20 | TCK, I/O |
| M1 | I/O |
| M2 | I/O |
| M3 | I/O |
| M4 | VCCI |
| M9 | GND |

Figure 53 • CQ172**Table 62 • CQ172**

| CQ172 | |
|------------|---------------------|
| Pin Number | A42MX16 Function |
| 1 | MODE |
| 2 | I/O |
| 3 | I/O |
| 4 | I/O |
| 5 | I/O |
| 6 | I/O |
| 7 | GND |
| 8 | I/O |
| 9 | I/O |
| 10 | I/O |
| 11 | I/O |
| 12 | VCC |
| 13 | I/O |
| 14 | I/O |
| 15 | I/O |
| 16 | I/O |
| 17 | GND |
| 18 | I/O |
| 19 | I/O |
| 20 | I/O |